

**12-Bit to 24-Bit Registered Bus Exchanger with 3-State Outputs**

**Product Features**

- PI74AVC+16268 is designed for low-voltage operation,  $V_{CC}=1.65V$  to  $3.6V$
- True  $\pm 24mA$  Balanced Drive @  $3.3V$
- $I_{OFF}$  supports partial power-down operation
- 3.6 I/O Tolerant Inputs and Outputs
- All outputs contain a patented DDC (Dynamic DriveControl) circuit that reduces noise without degrading propagation delay.
- Industrial operation:  $-40^{\circ}C$  to  $+85^{\circ}C$
- Available Packages:
  - 56-pin 240 mil wide plastic TSSOP (A)
  - 56-pin 173 mil wide plastic TVSOP (K)

**Product Description**

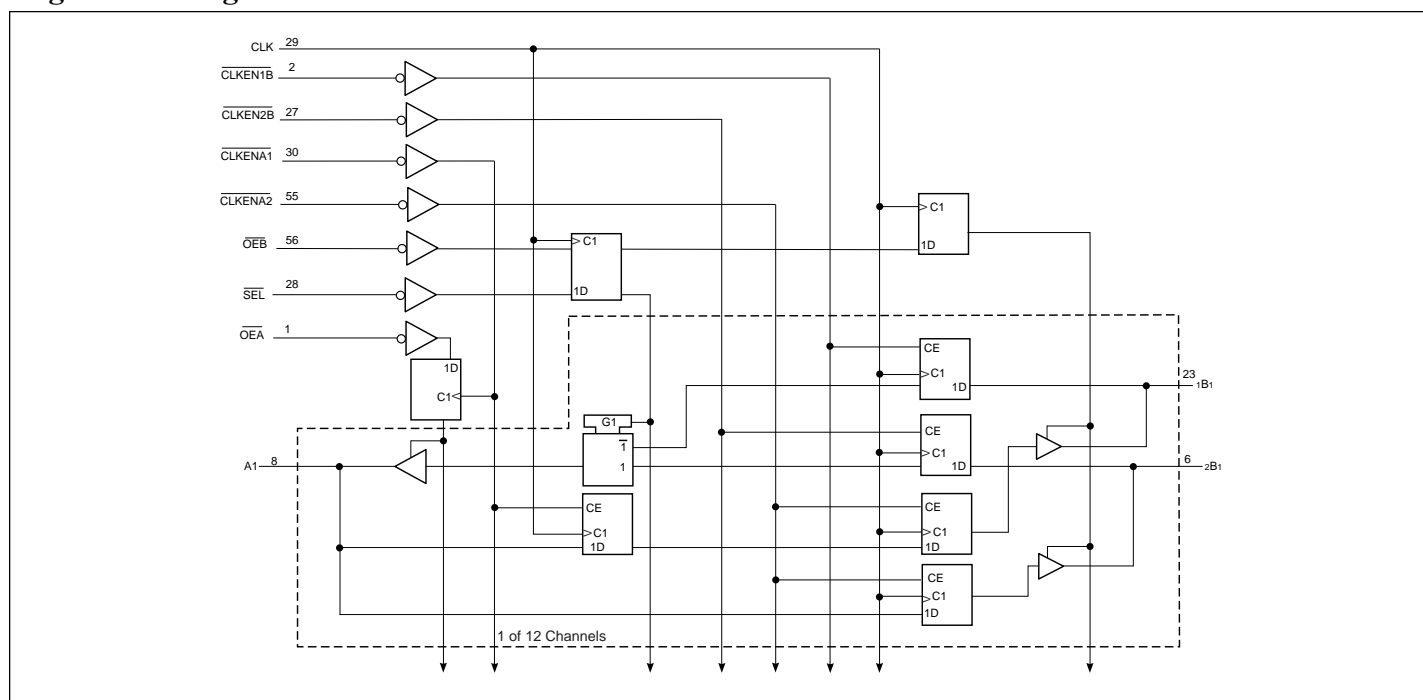
Pericom Semiconductor's PI74AVC+ series of logic circuits are produced using the Company's advanced submicron CMOS technology, achieving industry leading speed.

The PI74AVC+16268, a 12-bit to 24-bit registered bus exchanger designed for 1.65V to 3.6V  $V_{CC}$  operation, is used for applications in which data must be transferred from a narrow high-speed bus to a wide, lower frequency bus. It provides synchronous data exchange between the two ports. Data is stored in internal registers on the low-to-high transition of the clock (CLK) input when appropriate clock-enable ( $\overline{CLKEN}$ ) inputs are low. The select (SEL) line is synchronous with CLK and selects 1B or 2B input data for the A outputs.

For data transfer in the A-to-B direction, a two-stage pipeline is provided in the A-to-1B path, with a single storage register in the A-to-2B path. Proper control of these inputs allows two sequential 12-bit words to be presented synchronously as a 24-bit word on the B-port. Data flow is controlled by the active-low output enables ( $\overline{OEA}$ ,  $\overline{OEB}$ ). These control terminals are registered so bus direction changes are synchronous with CLK.

To ensure the high-impedance state during power up or power down, a clock pulse should be applied as soon as possible and  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor, the minimum value of the resistor is determined by the current-sinking capability of the driver. Because  $\overline{OE}$  is being routed through a register, the active state of the outputs cannot be determined prior to the arrival of the first clock pulse.

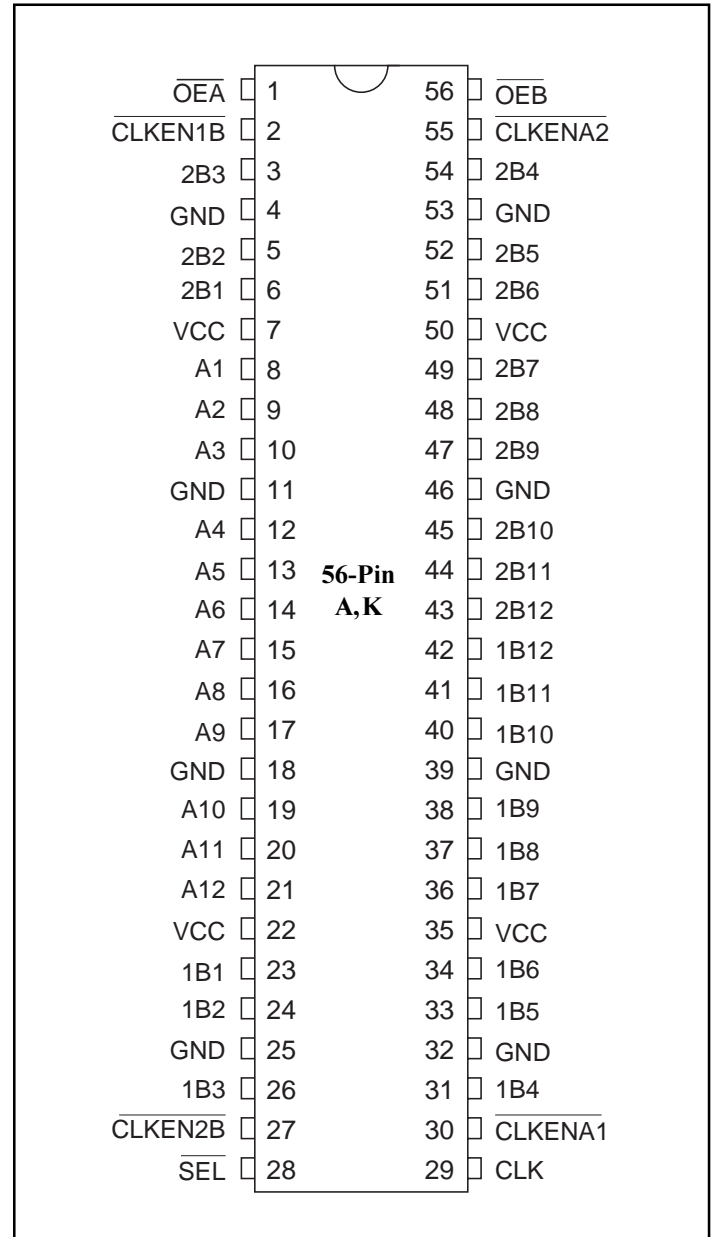
**Logic Block Diagram**



### Pin Description

Pin Name	Description
$\overline{OE}$	Output Enable Input (Active LOW)
CLK	Clock
$\overline{SEL}$	Select (Active Low)
$\overline{CLKEN}$	Clock Enable (Active Low)
A,1B,2B	3-State Outputs
GND	Ground
V <sub>CC</sub>	Power

### Pin Configuration



### Truth Tables<sup>(1)</sup>

#### Output Enable

Inputs			Outputs	
CLK	$\overline{OEA}$	$\overline{OEB}$	A	1B,2B
—	H	H	Z	Z
—	H	L	Z	Active
—	L	H	Active	Z
—	L	L	Active	Active

#### A to B STORAGE ( $\overline{OEB}=L$ )

Inputs			Outputs		
$\overline{CLKENA1}$	$\overline{CLKENA2}$	CLK	A	1B	2B
H	H	X	X	1B0 <sup>(2)</sup>	2B0 <sup>(3)</sup>
L	L	↑	L	L <sup>(2)</sup>	X
L	L	↑	H	H <sup>(2)</sup>	X
X	L	↑	L	X	L
X	L	↑	H	X	H

#### B to A STORAGE ( $\overline{OEA}=L$ )

Inputs						Outputs
$\overline{CLKEN1B}$	$\overline{CLKEN2B}$	CLK	$\overline{SEL}$	1B	2B	A
H	X	X	H	X	X	A0 <sup>(3)</sup>
X	H	X	L	X	X	A0 <sup>(3)</sup>
L	X	↑	H	L	X	L
L	X	↑	H	H	X	H
X	L	↑	L	X	L	L
X	L	↑	L	X	H	H

#### Notes:

1. H = High Signal Level, L = Low Signal Level, X = Irrelevant, Z = High Impedance, ↑ = Transition, Low to High
2. Two CLK edges are needed to propagate data
3. Output level before indicated steady state input conditions were established.



**Maximum Ratings**

(Above which the useful life may be impaired.  
 For user guidelines, not tested.)

Supply voltage range, $V_{CC}$ .....	-0.5V to +4.6V
Input voltage range, $V_I$ .....	-0.5V to +4.6V
Voltage range applied to any output in the high-impedance or power-off state, $V_O^{(1)}$ .....	-0.5V to +4.6V
Voltage range applied to any output in the high or low state, $V_O^{(1,2)}$ .....	-0.5V to $V_{CC}+0.5V$
Input clamp current, $I_{IK}$ ( $V_I < 0$ ) .....	-50mA
Output clamp current, $I_{OK}$ ( $V_O < 0$ ) .....	-50mA
Continuous output current, $I_O$ .....	$\pm 50mA$
Continuous current through each $V_{CC}$ or GND .....	$\pm 100mA$
Package thermal impedance, $\theta_{JA}^{(3)}$ : package A .....	64°C/W
package K .....	48°C/W
Storage Temperature range, $T_{stg}$ .....	-65°C to 150°C

**Note:**

Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

**Notes:**

1. Input & output negative-voltage ratings may be exceeded if the input and output current rating are observed.
2. Output positive-voltage rating may be exceeded up to 4.6V maximum if the output current rating is observed.
3. The package thermal impedance is calculated in accordance with JESD51.

**Recommended Operating Conditions<sup>(1)</sup>**

			<b>Min.</b>	<b>Max.</b>	<b>Units</b>
$V_{CC}$ Supply Voltage	Operating		1.65	3.6	V
	Data retention only		1.2		
$V_{IH}$ High-level Input Voltage	$V_{CC} = 1.2V$		$V_{CC}$		
	$V_{CC} = 1.65V$ to 1.95V		$0.65 \times V_{CC}$		
	$V_{CC} = 2.3V$ to 2.7V		1.7		
	$V_{CC} = 3V$ to 3.6V		2		
$V_{IL}$ Low-level Input Voltage	$V_{CC} = 1.2V$			GND	
	$V_{CC} = 1.65V$ to 1.95V			$0.35 \times V_{CC}$	
	$V_{CC} = 2.3V$ to 2.7V			0.7	
	$V_{CC} = 3V$ to 3.6V			0.8	
$V_I$ Input Voltage			0	3.6	
$V_O$ Output Voltage	Active State		0	$V_{CC}$	
	3-State		0	3.6	
$I_{OH}$ High-level output current	$V_{CC} = 1.65V$ to 1.95V			-6	
	$V_{CC} = 2.3V$ to 2.7V			-12	
	$V_{CC} = 3V$ to 3.6V			-24	
$I_{OL}$ Low-level output current	$V_{CC} = 1.65V$ to 1.95V			6	
	$V_{CC} = 2.3V$ to 2.7V			12	
	$V_{CC} = 3V$ to 3.6V			24	
$\Delta t_{\Delta v}$ Input transition rise or fall rate	$V_{CC} = 1.65V$ to 3.6V			5	ns/V
$T_A$ Operating free-air temperature			-40	85	°C

**Notes:**

1. All unused inputs must be held at  $V_{CC}$  or GND to ensure proper device operation.

**DC Electrical Characteristics** (Over the Operating Range,  $T_A = -40^\circ\text{C} + 85^\circ\text{C}$ )

Parameters		Test Conditions <sup>(1)</sup>	V <sub>CC</sub>	Min.	Max.	Units
V <sub>OH</sub>		I <sub>OH</sub> = -100μA	1.65V to 3.6V	V <sub>CC</sub> - 0.2V		V
		I <sub>OH</sub> = -6mA    V <sub>IH</sub> = 1.07V	1.65V	1.2		
		I <sub>OH</sub> = -12mA    V <sub>IH</sub> = 1.7V	2.3V	1.75		
		I <sub>OH</sub> = -24mA    V <sub>IH</sub> = 2V	3V	2.0		
V <sub>OL</sub>		I <sub>OL</sub> = 100μA	1.65V to 3.6V		0.2	V
		I <sub>OL</sub> = 6mA    V <sub>IH</sub> = 0.57V	1.65V		0.45	
		I <sub>OL</sub> = 12mA    V <sub>IH</sub> = 0.7V	2.3V		0.55	
		I <sub>OL</sub> = 24mA    V <sub>IH</sub> = 0.8V	3V		0.8	
I <sub>I</sub>	Control Inputs	V <sub>I</sub> = V <sub>CC</sub> or GND	3.6V		±2.5	μA
I <sub>OFF</sub>		V <sub>I</sub> or V <sub>O</sub> = 3.6V	0		±10	
I <sub>OZ</sub>		V <sub>I</sub> = V <sub>CC</sub> or GND	3.6V		±10	
I <sub>CC</sub>		V <sub>O</sub> = V <sub>CC</sub> or GND    I <sub>O</sub> = 0	3.6V		40	
C <sub>I</sub>	Control Inputs	V <sub>I</sub> = V <sub>CC</sub> or GND	2.5V		4	pF
			3.3V		4	
	Data Inputs		2.5V		6	
			3.3V		6	
C <sub>O</sub>	Outputs	V <sub>O</sub> = V <sub>CC</sub> or GND	2.5V		8	
			3.3V		8	

**Note:**

1. Typical values are measured at  $T_A = 25^\circ\text{C}$ .

**Timing Requirements** (Over Operating Range)

Parameters	Description		V <sub>CC</sub> = 1.2V		V <sub>CC</sub> = 1.5V ±0.1V		V <sub>CC</sub> = 1.8V ±0.15V		V <sub>CC</sub> = 2.5V ±0.2V		V <sub>CC</sub> = 3.3V ±0.3V		Units
			Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
f <sub>CLOCK</sub>	Clock frequency						150		180		180		MHz
t <sub>w</sub>	Pulse duration, CLK high or low					3		3		3			
t <sub>SU</sub>	Setup time	A data before CLK↑	2.2		2.2		2.0		1.5		1.5		ns
		B data before CLK↑	1.6		1.5		1.5		1.0		0.8		
		$\overline{SEL}$ before CLK↑	2.0		1.8		1.5		1.3		1.1		
		$\overline{CLKENA1}$ or $\overline{CLKENA2}$ before CLK↑	3.2		2.2		2.0		1.8		1.7		
		$\overline{CLKENB1}$ or $\overline{CLKENB2}$ before CLK↑	3.2		2.4		2.0		1.8		1.7		
		$\overline{OE}$ before CLK↑	3.2		2.5		2.2		2.2		2.0		
t <sub>H</sub>	Hold time	A data after CLK↑	0.5		0.5		0.2		0.2		0.1		ns
		B data after CLK↑	1.0		1.0		1.0		1.0		1.0		
		$\overline{SEL}$ after CLK↑	1.4		1.4		1.0		1.0		0.8		
		$\overline{CLKENA1}$ or $\overline{CLKENA2}$ after CLK↑	0		0		0.2		0.6		0.6		
		$\overline{CLKENB1}$ or $\overline{CLKENB2}$ after CLK↑	0		0		0.1		0.6		0.6		
		$\overline{OE}$ after CLK↑	0		0.2		0.2		0.5		0.5		

**Note:**

- Unused control inputs must be held HIGH or LOW to prevent them from floating.

**Switching Characteristics (Over Operating Range)**

Parameter	From (Input)	To (Output)	V <sub>CC</sub> = 1.2V	V <sub>CC</sub> = 1.5V ±0.1V		V <sub>CC</sub> = 1.8V ±0.15V		V <sub>CC</sub> = 2.5V ±0.2V		V <sub>CC</sub> = 3.3V ±0.3V		Units
			Typical	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
f <sub>max</sub>						150		180		180		MHz
t <sub>pd</sub>	CLK	B	8.1		5.0	2.0	4.8	1.8	4.0	1.3	3.1	ns
		A(1B)	9.0		5.5	2.1	5.0	1.7	4.2	1.2	3.4	
		B(2B)	8.0		5.5	2.1	5.0	1.8	4.3	1.3	3.4	
		A(SEL)	9.3		6.5	2.5	5.4	2.4	4.3	1.7	3.6	
t <sub>en</sub>	CLK	B	9.3		6.4	2.8	5.8	2.6	4.4	1.8	3.8	
t <sub>dis</sub>		B	9.0		7.0	3.0	6.0	2.5	3.8	1.8	3.8	
t <sub>en</sub>		A	9.0		6.5	2.1	5.5	1.8	4.2	1.3	3.6	
t <sub>dis</sub>		A	8.8		6.3	2.3	5.5	2.1	3.5	1.5	3.8	

**Notes:**

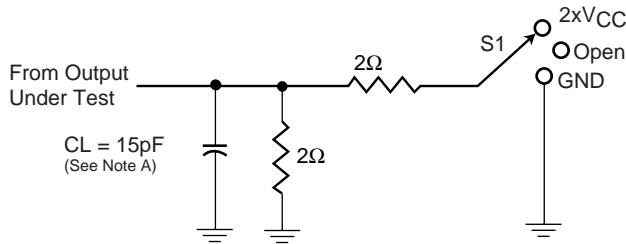
1. Unused control inputs must be held HIGH or LOW to prevent them from floating.
2. Minimum limits are guaranteed but not tested on Propagation Delays.

**Operating Characteristics, T<sub>A</sub> = 25°C**

Parameters		Test Conditions	V <sub>CC</sub> = 1.8V ±0.15V	V <sub>CC</sub> = 2.5V ±0.2V	V <sub>CC</sub> = 3.3V ±0.3V	Units
			Typical	Typical	Typical	
Cpd Power Dissipation Capacitance	Outputs Enabled	C <sub>L</sub> = 0pF, f = 10 MHz	60	65	76	pF
	Outputs Disabled		40	45	55	

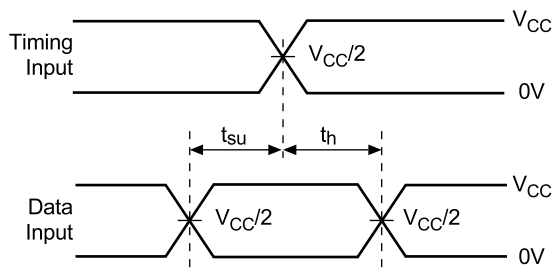
PARAMETER MEASUREMENT INFORMATION

$V_{CC} = 1.2V$  and  $1.5V \pm 0.1V$

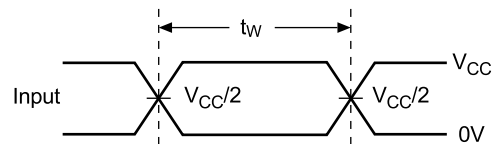


Load Circuit

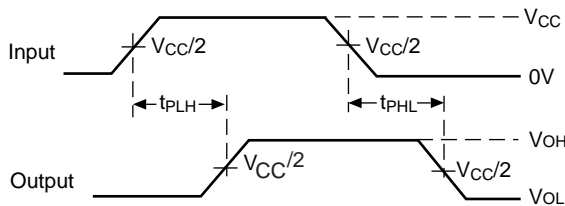
Test	S1
$t_{pd}$ $t_{PLZ}/t_{PZL}$ $t_{PHZ}/t_{PZH}$	Open $2 \times V_{CC}$ GND



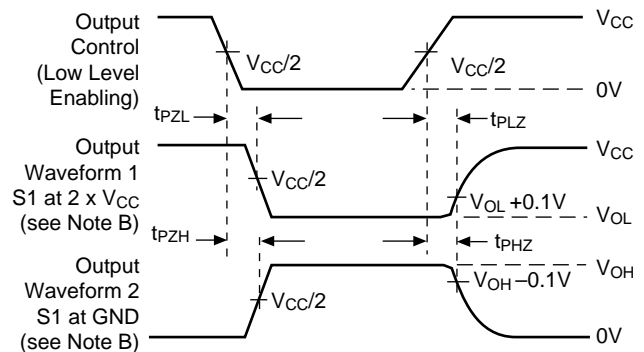
Voltage Waveforms  
Setup and Hold Times



Voltage Waveforms  
Pulse Duration



Voltage Waveforms  
Propagation Delay Times



Voltage Waveforms  
Enable and Disable Times

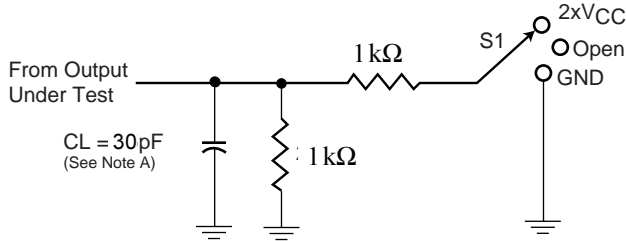
Figure 1. Load Circuit and Voltage Waveforms

Notes:

- A.  $C_L$  includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.  
Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input impulses are supplied by generators having the following characteristics:  $PRR \leq 10$  MHz,  $Z_O = 50\Omega$ ,  $t_R \leq 2.0ns$ ,  $t_F \leq 2.0ns$ .
- D. The outputs are measured one at a time with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$

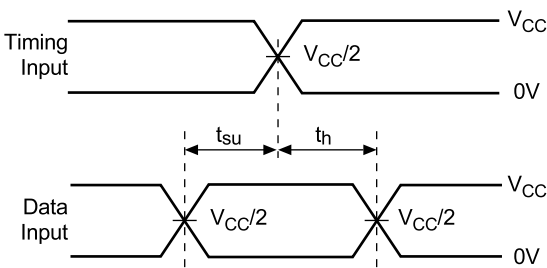
PARAMETER MEASUREMENT INFORMATION

$V_{CC} = 1.8V \pm 0.15V$

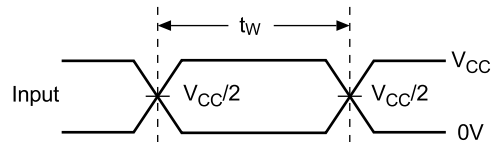


Load Circuit

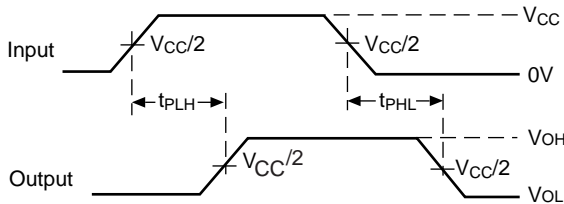
Test	S1
$t_{pd}$ $t_{PLZ}/t_{PZL}$ $t_{PHZ}/t_{PZH}$	Open $2 \times V_{CC}$ GND



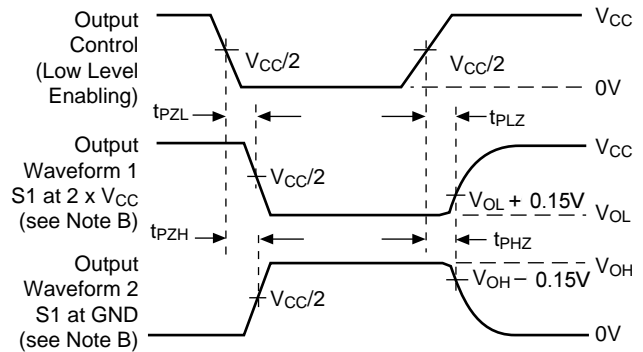
Voltage Waveforms  
Setup and Hold Times



Voltage Waveforms  
Pulse Duration



Voltage Waveforms  
Propagation Delay Times



Voltage Waveforms  
Enable and Disable Times

Figure 2. Load Circuit and Voltage Waveforms

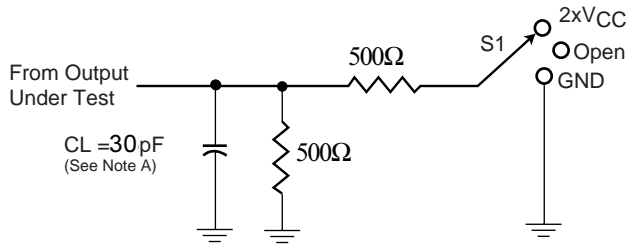
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- C. All input impulses are supplied by generators having the following characteristics:  $PRR \leq 10 \text{ MHz}$ ,  $Z_O = 50\Omega$ ,  $t_R \leq 2.0\text{ns}$ ,  $t_F \leq 2.0\text{ns}$ .
- D. The outputs are measured one at a time with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$



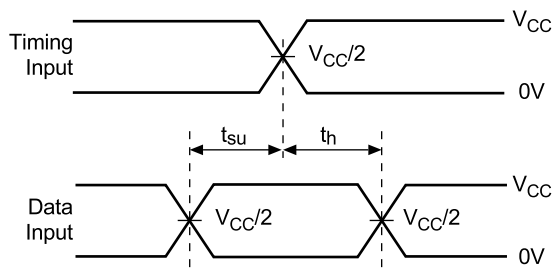
PARAMETER MEASUREMENT INFORMATION

$V_{CC} = 2.5V \pm 0.2V$

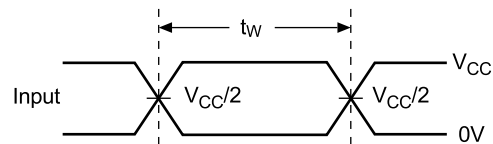


Load Circuit

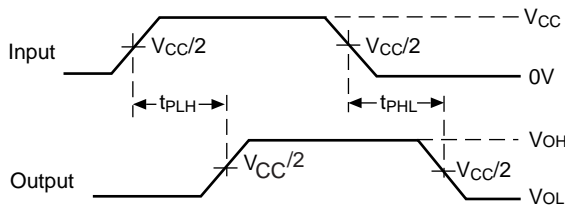
Test	S1
$t_{pd}$ $t_{PLZ}/t_{PZL}$ $t_{PHZ}/t_{PZH}$	Open $2 \times V_{CC}$ GND



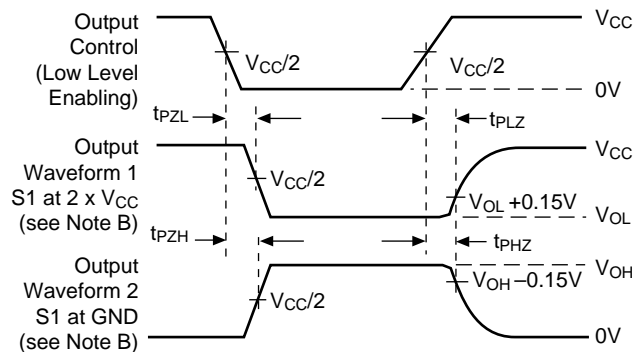
Voltage Waveforms  
Setup and Hold Times



Voltage Waveforms  
Pulse Duration



Voltage Waveforms  
Propagation Delay Times



Voltage Waveforms  
Enable and Disable Times

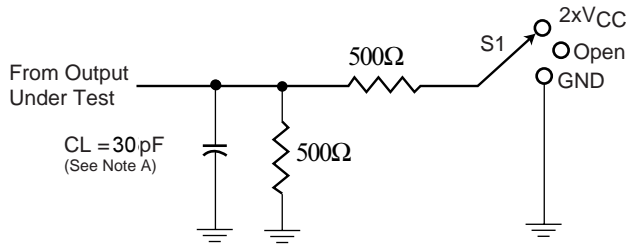
Figure 3. Load Circuit and Voltage Waveforms

Notes:

- A.  $C_L$  includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.  
Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input impulses are supplied by generators having the following characteristics:  $PRR \leq 10 \text{ MHz}$ ,  $Z_O = 50\Omega$ ,  $t_R \leq 2.0\text{ns}$ ,  $t_F \leq 2.0\text{ns}$ .
- D. The outputs are measured one at a time with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$

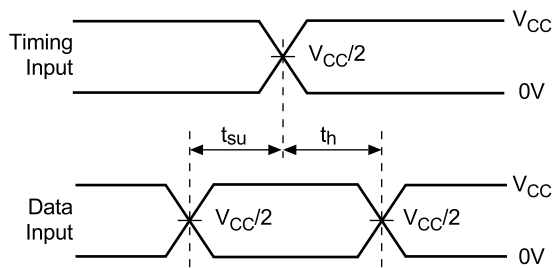
PARAMETER MEASUREMENT INFORMATION

$V_{CC} = 3.3V \pm 0.3V$

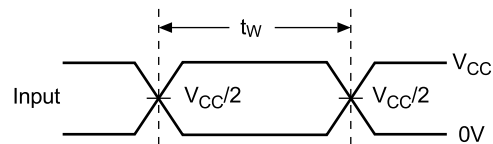


Load Circuit

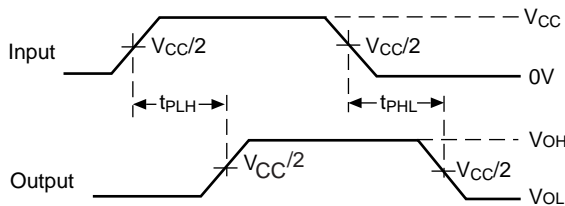
Test	S1
$t_{pd}$ $t_{PLZ}/t_{PZL}$ $t_{PHZ}/t_{PZH}$	Open $2 \times V_{CC}$ GND



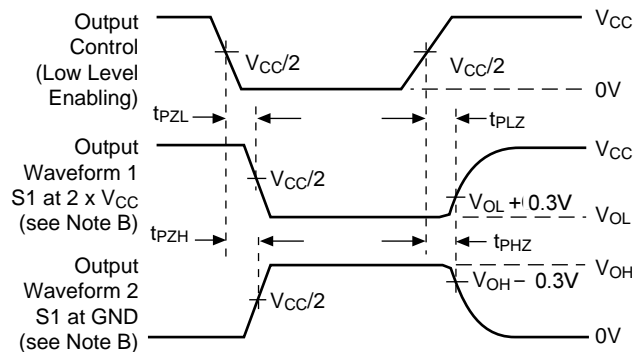
Voltage Waveforms  
Setup and Hold Times



Voltage Waveforms  
Pulse Duration



Voltage Waveforms  
Propagation Delay Times



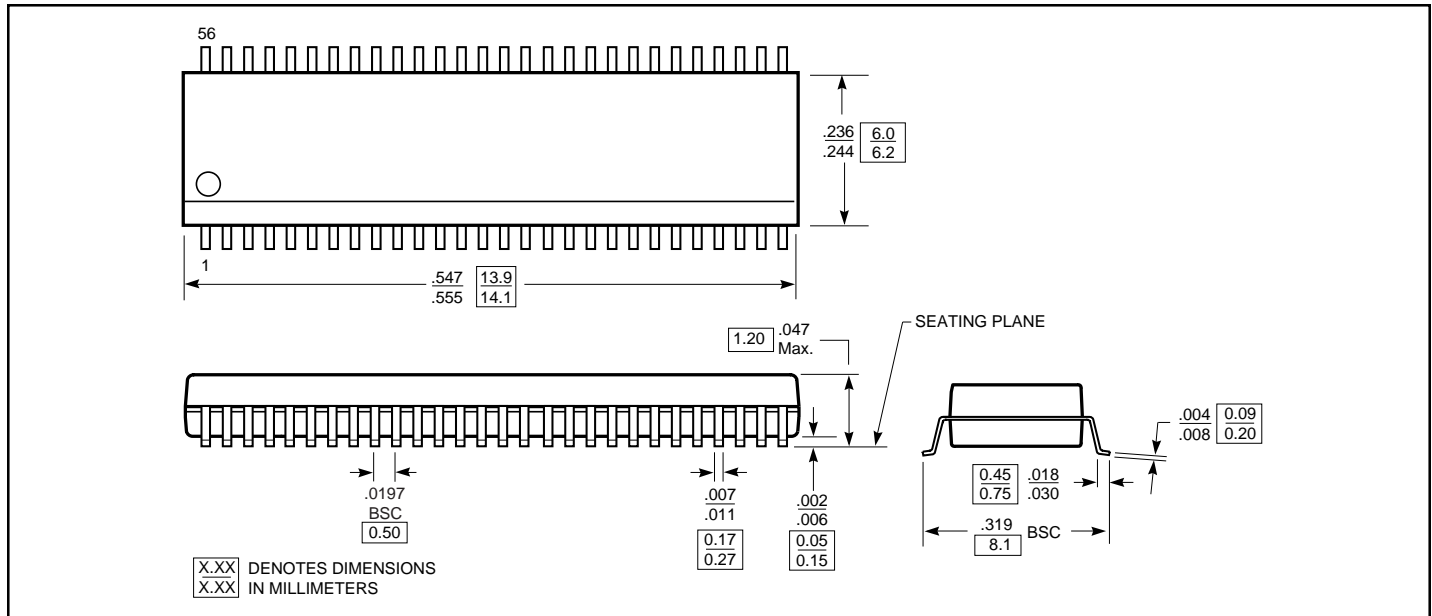
Voltage Waveforms  
Enable and Disable Times

Figure 4. Load Circuit and Voltage Waveforms

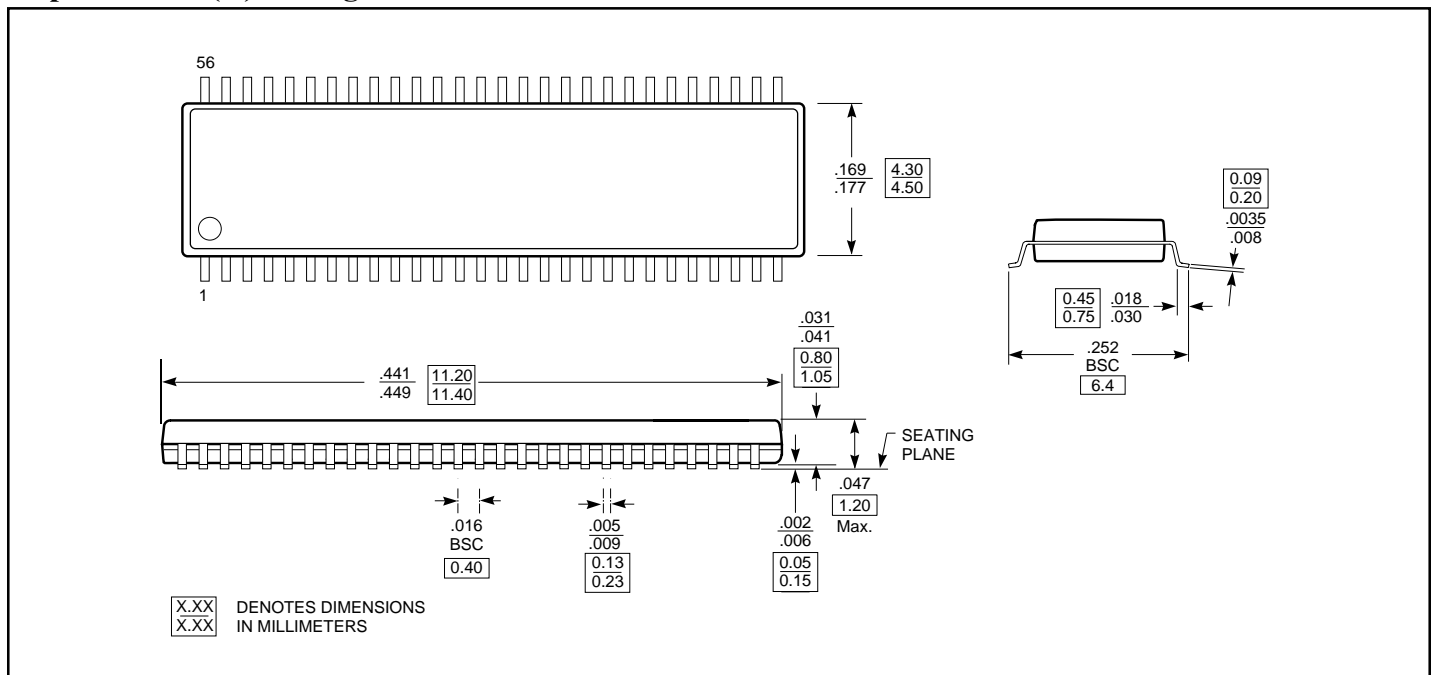
Notes:

- A.  $C_L$  includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input impulses are supplied by generators having the following characteristics:  $PRR \leq 10 \text{ MHz}$ ,  $Z_O = 50\Omega$ ,  $t_R \leq 2.0\text{ns}$ ,  $t_F \leq 2.0\text{ns}$ .
- D. The outputs are measured one at a time with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$

### 56-pin TSSOP (A) Package



### 56-pin TVSOP (K) Package



### Ordering Information

Ordering Data	Description
PI74AVC+16268A	56-pin, 240 mil wide plastic TSSOP
PI74AVC+16268K	56-pin, 173 mil wide plastic TVSOP